

Search Notes

Application/Control No.

10/756,360

Examiner

Granvill D. Lee Jr

Applicant(s)/Patent under
Reexamination

BAIER ET AL.

Art Unit

2891

SEARCHED

Class	Subclass	Date	Examiner
438	68	4/19/2005	GL
438	113-114	4/19/2005	GL
438	401	4/19/2005	GL
438	457-460	4/19/2005	GL
438	462,494	4/19/2005	GL
438	498,504	4/19/2005	GL
438	589,620	4/19/2005	GL
438	667-668	4/19/2005	GL
438	735	4/19/2005	GL
257	118,244	4/19/2005	GL
257	618	4/19/2005	GL
257	622-623	4/19/2005	GL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See East	4/19/2005	GL